Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/694,243	BAO ET AL.	
Examiner	Art Unit	
D.L. Jones	1618	

SEARCHED				
Class	Subclass	Date	Examiner	
424	1.11 1.29 1.45 1.49 1.53 9.3	1/30/2006	DJ	
424	1.65 1.69	1/30/2006	ฌ	
424	9.1 9.323	1/30/2006	מ	
424	9.32 9.321	1/30/2006	DJ	
424	9.322 9.32	1/30/2006	DJ	
424	9.34 9.36	1/30/2006	DΊ	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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